

The Cross-Over L-Designs for Symmetric Parallel Line

Assays

蔡風順

中央研究院統計科學研究所

Abstract

A cross-over L-design, which can estimate preparation, combined regression and parallelism contrasts with full information, for symmetric parallel line assays is defined and characterized. In this talk, several classes of cross-over L-designs are constructed, including the major class $D(v, n=16, p=v, r=16)$.